Application/Control No.	Applicant(s)/Patent unde Reexamination	r
09/489,600	GETSIN ET AL.	
Examiner	Art Unit	
Dustin Nauven	2154	

SEARCHED				
Class	Subclass	Date	Examiner	
348	14, 515	5/12/2005	DN	
709	204, 248	5/12/2005	DN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
348	14, 515	5/12/2005	DN	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
updated EAST search, consult w/ Viet Vu on McPherson reference, searches ACM, IEEE, google	5/12/2005	DN		